

Notice of References CitedApplication/Control No.
10/064,721Applicant(s)/Patent Under
Reexamination
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1712

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,486,261	11-2002	Wu et al.	525/332.6
	C	US-			
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	I	US-			
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Chemical Abstract registry # 101-96-2
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